

**Search Notes**

Application/Control No.

10/632,475

Examiner

Truc T. T. Nguyen

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2833

**SEARCHED**

Class	Subclass	Date	Examiner
439	636-637 62-65 660	5/10/2005	TN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
same as searched above		5/10/05	

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR